Fo	orm PTO-1449 (modified)		Atty. Docket No.	Serial No.
SIPE	,		WRKS:002	09/717.728
	of Patents and Publications for	Applicant's	Applicant	
1 3			C. Todd Praisner et	al.
SEP 0 6 2002	NFORMATION DISCLOSURE S			
	7		Filing Date:	Group:
RADEMEN OF	(Use several sheets if necess	ary)	November 21, 2000	2164
RADEN	U.S. Patent Documents	Foreign Pa	atent Documents	Other A
3	See Page 1	Se	e Page 1	See Pag

Group:	
2164	

Other Art

See Page 1

U.S. Patent Documents

Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date if App.
MA	A18	5,914,472	6/22/99	Foladare et al.			
MA NOT	A19	5,953,710	9/14/99	Fleming			

Foreign Patent Documents

Exam. Init.	Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No
M	B1	GB 2 326 011	12/9/98	UK			Yes
M	B2	0 485 090 A2	10/25/91	EP			Yes
M	В3	WO98/39743	9/11/98	PCT			Yes - Abstract only

Other Art (Including Author, Title, Date, Pertinent Pages, Etc.)

Exam. Init.	Ref. Des.	Citation
	C1	International Search Report dated August 27, 2002

RECEIVED SEP 1 0 2002 **GROUP 3600**

Examiner:	Marso	Date	Considered:	6/2	4	104	
	- V (J V V V)			V			

EXAMINER: initial if reference considered, whether or not citation is in conformance with MPEP609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form	PTO-	1449 (modified)		Atty. Docket N	1 0.		Serial	
				WRKS:002	WRKS:002 09/717.728			7.728
TENOT P	atents an	nd Publications fo	or Applicant's	Applicant				
~ (C)			C. Todd Prais	ner et a	1.			
		N DISCLOSURE	STATEMENT	Filia - Data			0	
6 2002	(Use se	veral sheets if neces	ssary)	Filing Date: November 21	2000		Group 2164): -
		Documents	Foreign	Patent Document				Other Art
DEMIC	See P			See Page 1				ee Page 1
			U.S. Pat	ent Docume	ents	-		
Exam. Init.	Ref. Des.	Document Number	Date	Name 	Class		Sub lass	Filing Date i App.
NA	A20	4,812,628	3/14/89	Boston et al.				
nas	A21	6,434,607	8/13/02	Haverstock et al.				1
mf	A22	6,438,690	8/20/02	Patel et al.			n	CEIVE
WA	A23	6,295,536	9/25/01	Sanne			H	SEP 2 0 2002
WA	A24	6,401,131	6/4/02	Haverstock et al.				SEP JO 3
M	A25	5,758,327	5/26/98	Gardner et al.			G	ROUP 3
MA	A26	5,361,199	11/1/94	Shoquist et al.			<u> </u>	
7-7-			Foreign P	atent Docur	nents	5		
Exam. Init.	Ref. Des.	Document Number	Date	Country	Class		Sub lass	Translation Yes/No
				-				
	·		-					
C	ther A	Art (Includi	ng Autho	r, Title, Date	, Pert	tinen	t Pa	ges, Etc.)
Exam.	Ref.	T		Citatio				<u> </u>
Init.	Des.							

Examiner: **Date Considered:**

EXAMINER: initial if reterence considered, whether or not citation is in conformance with MPEP609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

				. >				Page 1 o		
,			1449 (modified)	· · · · · · · ·	Atty. Docket WRKS:002	No. 7,728				
E	JEST OF P		d Publications fo		Applicant					
	400 1VE	PRMATIO	N DISCLOSURE	STATEMENT		<u></u>				
ART O	A INC	(Use se	veral sheets if neces	ssary)	Filing Date: November 2	1, 2000	Group	:		
PATER	7 & TEP U.S	S. Patent	Documents	Foreig	n Patent Docume		0	ther Art		
AIE		See Page 1 Se					See	Page N/A		
		<u>.</u>		U.S. Pa	tent Docum	ents				
	Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date if App.		
	MI	A27	6,226,624	5/1/02	Watson et al.	705	44			
				· · -			· ·			
				Foreign I	Patent Docu	ments				
	Exam. Init.	Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No		
		Other A	Art (Includii	ng Autho	or, Title, Date	e, Pertin	ent R	ECENE		
	Exam. Init.	Ref. Des.			Citati			MAR 1 1 2003		
							GR	OUP 36		

Examiner: **Date Considered:**

EXAMINER: initial if reference considered, whether or not citation is in conformance with MPEP609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.